



## The Tiger Ben educational NCRE paperless to dedicated exam: two Access the exam special) (with CD + learning card a (2013)(Chinese Edition)

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HU BEN JIAO YU JIAO YAN ZHONG XIN

paperback. Book Condition: New. Ship out in 2 business day, And Fast shipping, Free Tracking number will be provided after the shipment. Paperback. Pub Date: October 2012 Pages: 194 Language: Chinese in Publisher: Beijing Institute of Technology Press. Tiger Ben Education NCRE paperless dedicated Exam: the two Access (2013 exam special) The questions are real exam the prototype question. questions types include multiple choice questions and hands-on operating questions. knowledge point completely cover the latest real test exam. and year by year continually updated to Zhenti core tissue contents of the book. while providing the exam TEST KEY questions. Book supporting software fully simulate the real exam environment. including the four major functional modules: multiple-choice questions and operating questions daily practice system. strengthening exercises system. complete simulation of the simulation test system. and live-action high-definition the teacher lecture hall system. Software with all the answers to the questions. convenient candidates need to access or print. Contents: Part 1 machine Exam Guide 1.1.1 machine test Note 1.1.2 on test environment 1.1.3 on test process Part 2 on multiple-choice test sites data structures and algorithms test sites program design basis of test sites software engineering test center 4 database design basis test sites...

### Reviews

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